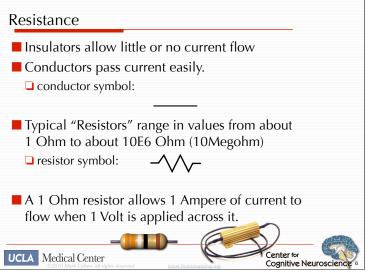
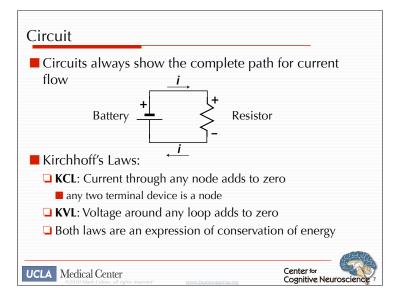
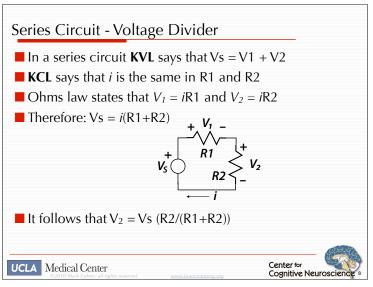


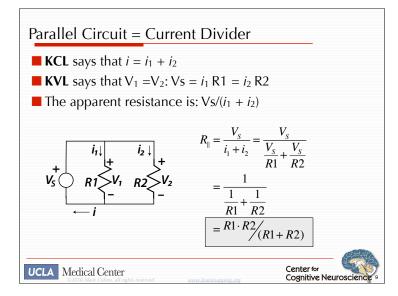
Cognitive Neurosci

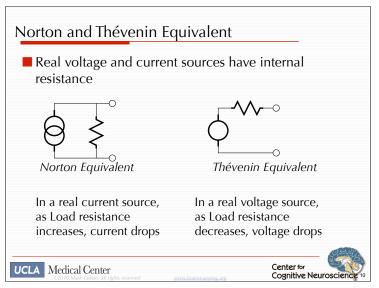
UCLA Medical Center

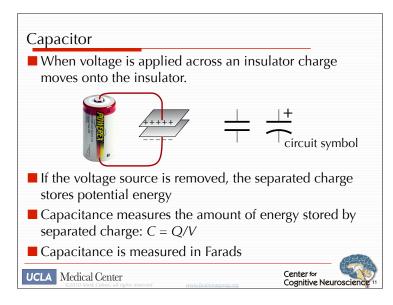


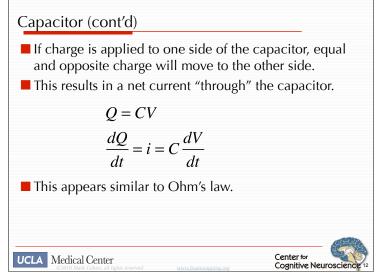


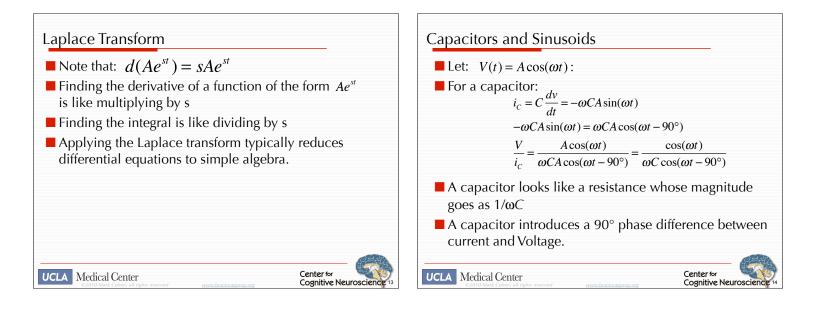


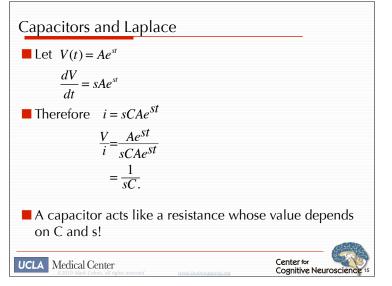


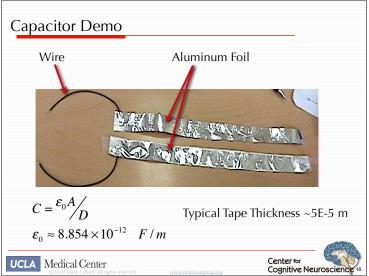


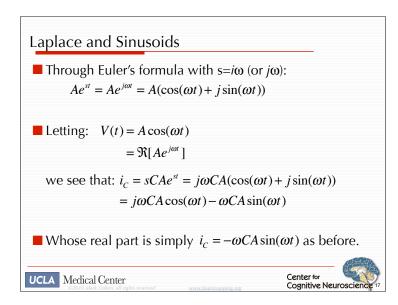


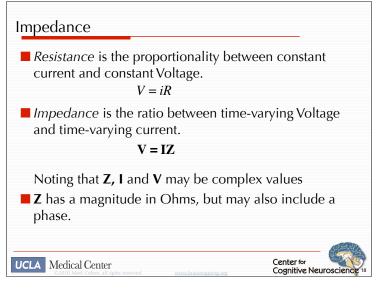


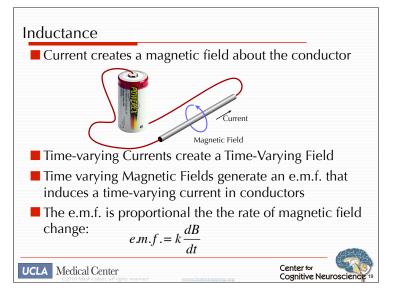


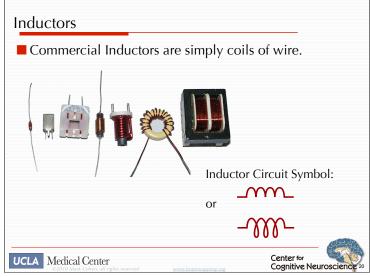


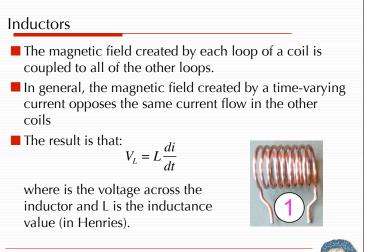






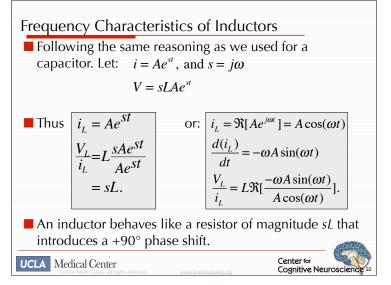


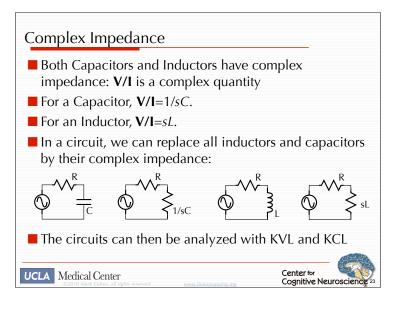


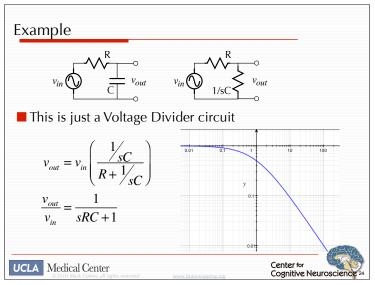


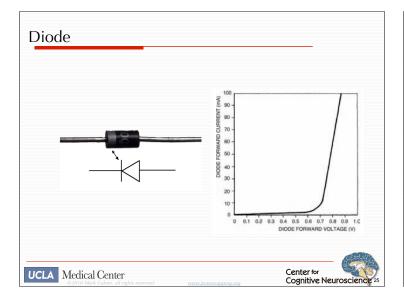
UCLA Medical Center

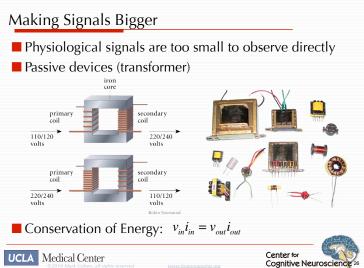


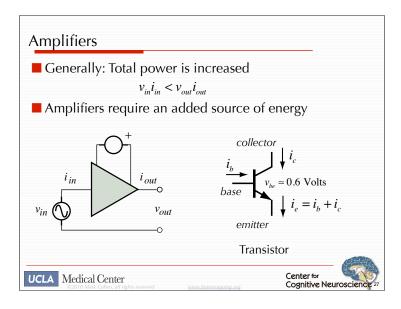


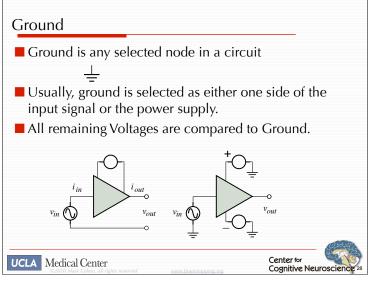


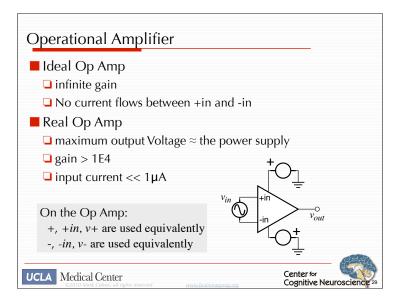


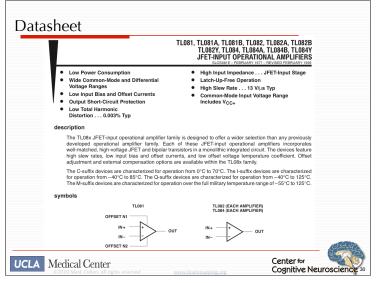






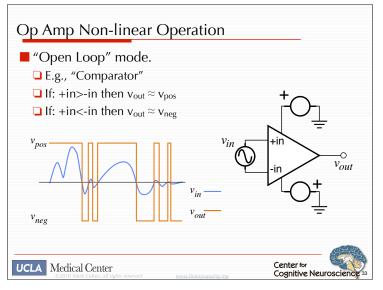


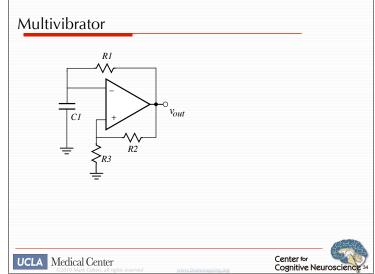




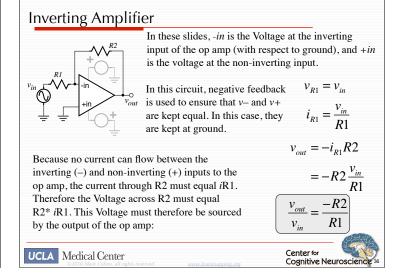
electrica	al characteristics	, V _{CC±} =	±15 V (unl	ess othe	rwise	noted	I)											
PARAMETER		TEST CONDITIONS		τ _A †	TL081C TL082C TL084C		TL081AC TL082AC TL084AC			TL081BC TL082BC TL084BC		TL081I TL082I TL084I		UNIT				
<u> </u>		<u> </u>		25°C	MIN	TYP	MAX 15	MIN	TYP 3	MAX 6	MIN	TYP 2	MAX 3	MIN	TYP 3	MAX 6	-	
VIO	Input offset voltage	VO = 0	$R_S = 50 \Omega$	Full range			20			7.5		-	5		-	9	mV	
αVIO	Temperature coefficient of input offset voltage	V _O = 0	R _S = 50 Ω	Full range		18			18			18			18		µV/°C	
10	Input offset current \$	Vo = 0		25°C		5	200		5	100		5	100		5	100	pA	
-10	input offset current -	.0-1		Full		~~	4	00		2			2			10	nA	
1B	Input bias current \$	VO = 0		Full		30	4	00	30	200	-	30	200		30	200	pA nA	
VICR	Common-mode input voltage range			25°C	±11	-12 to 15		±11	-12 to 15	,	±11	-12 to 15	,	±11	-12 to 15	20	v	
		RL = 10 kΩ		25°C	±12	±13.5		±12	± 13.5		±12	±13.5		±12	±13.5			
VOM	Maximum peak output voltage swing	$R_L \ge 10 \text{ k}\Omega$ $R_L \ge 2 \text{ k}\Omega$		Full range	±12	_	_	±12	±12	_	±12 ±10	±12		±12 ±10	±12		v	
AVD	Large-signal differential voltage amplification	-	$R_L \ge 2 k\Omega$ $R_L \ge 2 k\Omega$	Eul of	25	20	0		200		50 25	200	_	50 25	200		V/mV	
B1	Unity-gain bandwidth			25				-	3	-		3	-		3		MHz	
r,	Input resistance			25"		1012	2		1012			1012			1012		Ω	
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} V _O = 0,	min, Rg = 50 Ω	25°C	70	00	-	75	86	_	75	86		75	86		dB	
KSVR	Supply voltage rejection ratio ($\Delta V_{CC\pm} / \Delta V_{IO}$)	V _{CC} = ±15 V _O = 0,	V to \pm 9 V, R _S = 50 Ω	25°C	70	86		80	86		80	86		80	86		dB	
ICC	Supply current (per amplifier)	$V_{O} = 0,$	No load	25°C		1.4	2.8		1.4	2.8		1.4	2.8		1.4	2.8	mA	
		Avp = 100		25°C		120			120			120			120		dB	
TL08_BC ‡ Input bias	teristics are measured u and40°C to 85°C for T currents of a FET-input o tain the junction temperat	L08_I. operational an	plifier are norm	nal junction re	everse ci	urrents, v												-

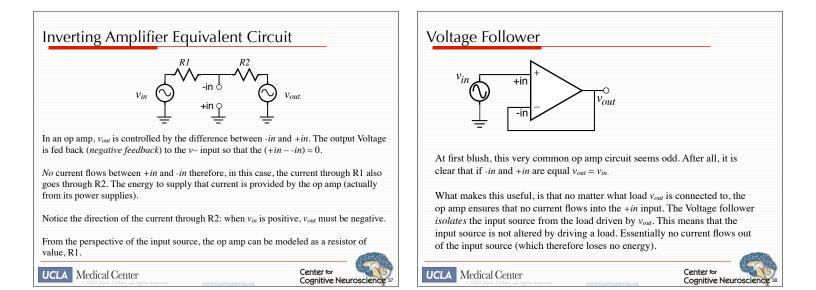
	TL081	JFET-IN	, TL081B (, TL084, IPUT OPI DS081E - FEBF	TL084A, ERATION	FL084B, T Al Ampl	LO84Y
absolute maximum ratings over opera	ting free-air to	emperatu	re range (unless otl	herwise n	oted)†
	_	TL08_C TL08_AC TL08_BC	TL08_I	TL084Q	TL08_M	UNIT
Supply voltage, V _{CC+} (see Note 1)	18	18	18	18	v	
Supply voltage V _{CC} - (see Note 1)	-18	-18	-18	-18	V	
Differential input voltage, VID (see Note 2)	± 30	± 30	± 30	± 30	v	
Input voltage, VI (see Notes 1 and 3)	±15	±15	±15	±15	V	
Duration of output short circuit (see Note 4)	unlimited	unlimited	unlimited	unlimited		
Continuous total power dissipation			See Dissi	pation Rating	Table	
Operating free-air temperature range, TA	0 to 70	- 40 to 85	- 40 to 125	- 55 to 125	°C	
Storage temperature range, T _{stg}	- 65 to 150	- 65 to 150	- 65 to 150	- 65 to 150	°C	
Case temperature for 60 seconds, TC	FK package				260	°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds	J or JG package				300	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	D, N, P, or PW package	260	260	260		°C
Stresses beyond those listed under "absolute maximum functional operation of the device at these or any other implied. Exposure to absolute-maximum-rated condition NOTES: 1. All voltage values, except differential voltage 2. Differential voltages are at 1N+ with respec- 3. The output may be shorted to ground or to dissipation rating is not exceeded.	conditions beyond ns for extended peri ges, are with respec t to IN ever exceed the ma	those indicate ods may affec t to the midpo gnitude of the	ed under "reco t device reliab int between V(supply voltage	mmended ope ility. CC + and VCC e or 15 V, white	erating conditions in the second s	ons" is not

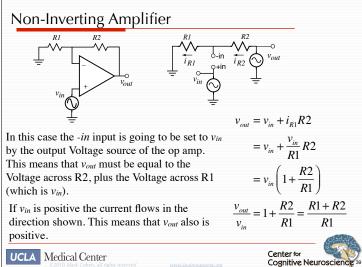


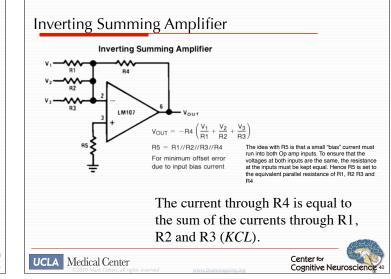


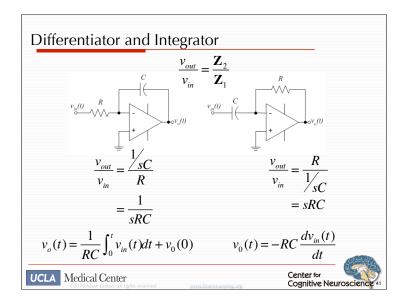
Linear Operation for Op Amps	
Negative Feedback	
■ +in ≈ -in	
$-v_{cc} < v_{out} < +v_{cc}$	
 Voltage at inverting (v-, or -in) and non (v+, or +in) inputs is equal. No current flows between these inputs v_{out} is adjusted as needed for the above 	U
UCLA Medical Center	Center for Cognitive Neuroscience 35

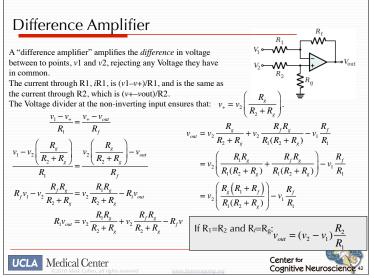


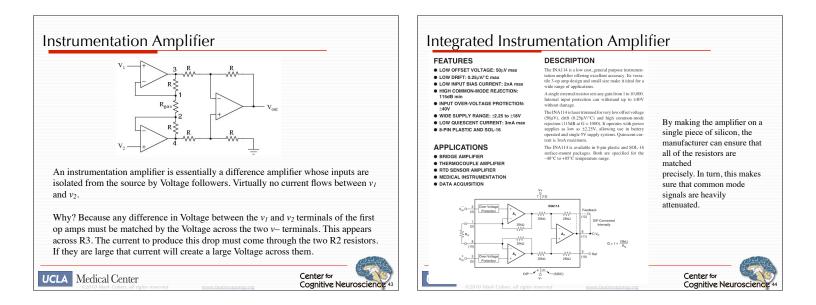


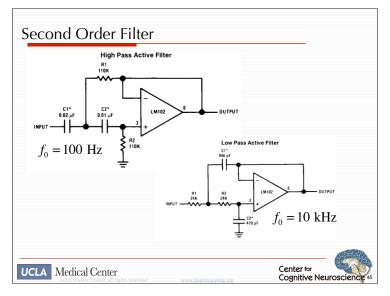


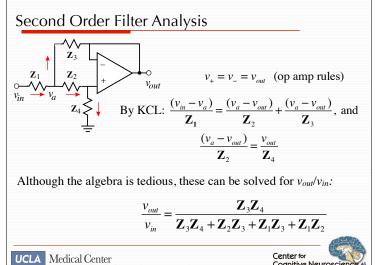












Cognitive Neuros

